

Search Notes**Application/Control No.**

09/773,090

Examiner

Chau Nguyen

Applicant(s)/Patent under Reexamination

SELLEN ET AL.

Art Unit

2176

SEARCHED

Class	Subclass	Date	Examiner
715	526	9/11/2006	CN
715	530-531	9/11/2006	CN
715	700	9/11/2006	CN
715	711	9/11/2006	CN
345	156	9/11/2006	CN
345	676	9/11/2006	CN

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Discussed with Primary William Bashore	9/7/2006	CN
Updated Search on East Reports	9/8/2006	CN
	9/11/2006	CN
NPL search on IEEE Database	9/11/2006	CN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
715	530-531	9/11/2006	CN
715	526	9/11/2006	CN
715	700, 711	9/11/2006	CN
345/156,676		9/11/2006	CN